

Notice of References Cited	Application/Control No. 10/670,523		Applicant(s)/Patent Under Reexamination IBUKA ET AL.	
	Examiner TAN X. DINH		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0103634 A1	06-2003	Ito, Tsuyoshi	381/86
*	B	US-2004/0106392 A1	06-2004	Yamasaki et al.	455/352
*	C	US-2004/0062402 A1	04-2004	Fujita et al.	381/018
*	D	US-7,006,645 B2	02-2006	Fujita et al.	381/307
*	E	US-6,957,134 B2	10-2005	Ramseyer et al.	381/86
*	F	US-7,190,798 B2	03-2007	Yasuhara, Toshiyuki	381/86
*	G	US-2003/0215102 A1	11-2003	Marlowe, Ira	381/86
*	H	US-2003/0012389 A1	01-2003	Brice et al.	381/86
*	I	US-5,420,931 A	05-1995	Donner, Irah H.	381/86
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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